

Caracterizarea suprafetelor nanostructurate de aur prin observarea alinierii moleculelor de cristale lichide

*Ligia Frunza, Traian Beica, Irina Zgura,
Florin Cotorobai, Stefan Frunza*

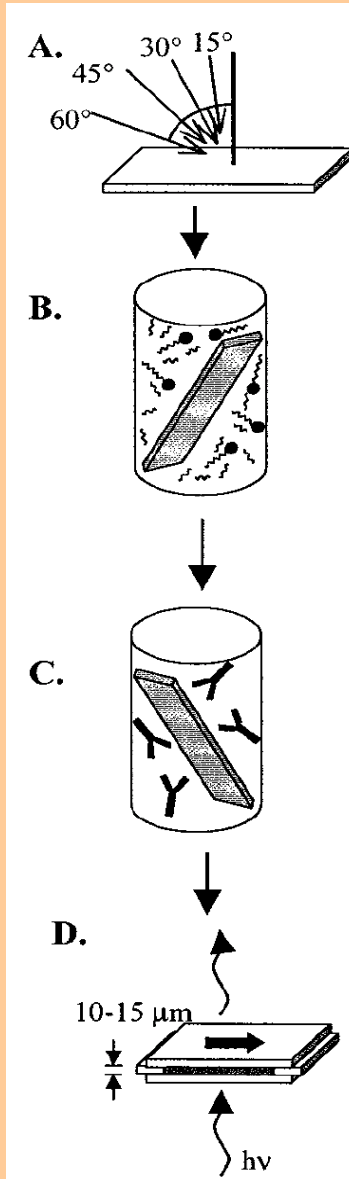
Institutul National de Cercetare Dezvoltare pentru Fizica Materialelor

Corneliu N. Zaharia

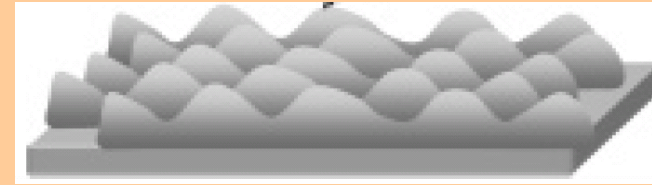
Institutul de Virusologie Stefan S. Nicolau al Academiei Romane

Seminarul National de Nanostiinta si Nanotehnologie, 16 martie 2010

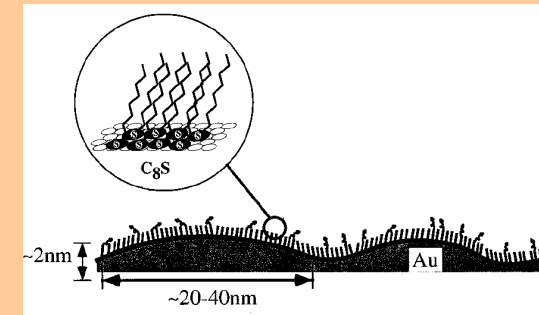
Motivare



Depunerea unor straturi subtiri nanostructurate de aur



Functionalizare prin formarea de straturi autoasamblate (SAM) de tioli (C_nSH si $BiSH$).



Legarea anti-Bi IgG

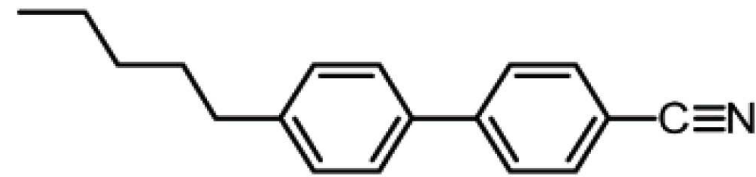
(15 x 10 x 5 nm)



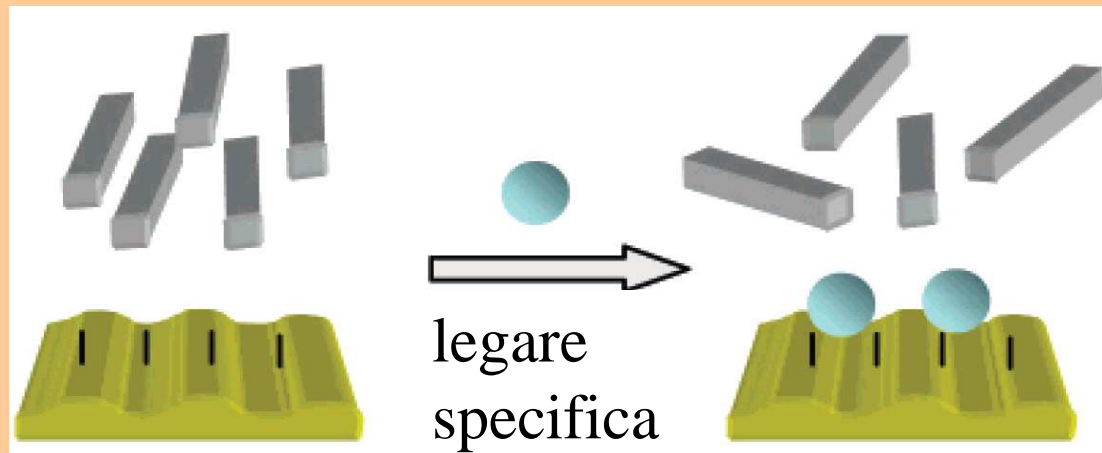
Inspectia optica a cristalului lichid aflat intre doua straturi SAM care suporta IgG legata.

N.L. Abbott's Group /Langmuir 2001, 17, 5448-5457; 5595-5604

Cristalul lichid



4-pentyl-4' cyanobiphenyl
5CB



**Cristalul lichid nematic 5CB este folosit pentru a depista existenta unor biomolecule la interfete:
legarea proteinei modifica ordonarea moleculelor in apropierea suprafetei**

Experimental

A

Placuta de sticla



Aur la incidenta oblica
Stabilire conditii
Caracterizare



Celule cu cristal lichid

B

Placuta de sticla



Polistiren



Aur la incidenta oblica



Functionalizare



Caracterizare



Celule cu cristal lichid

Experimental

Materiale

Placute de sticla (32x23x3 mm)
Polistiren
Aur
Alcantiol (C16SH)
Cristal lichid 5CB

Metode de depunere

Spin coating
Depunere in vacuum la unghi de incidenta mic

Metode de caracterizare

AFM

Park XE-150 (Schaefer)

XPS

VG ESCA MkII

XRD la unghi razant

Advance D8 (Bruker)

Spectroelipsometrie

DUV-VIS-XNIR Variable Angle

Spectroscopie Raman

RFS 100/S (Bruker)

FTIR

SPECTRUM BX (Perkin Elmer)

UV-VIS

Lambda 45 (Perkin Elmer)

Unghi de contact

DSA 100 (Kruess)

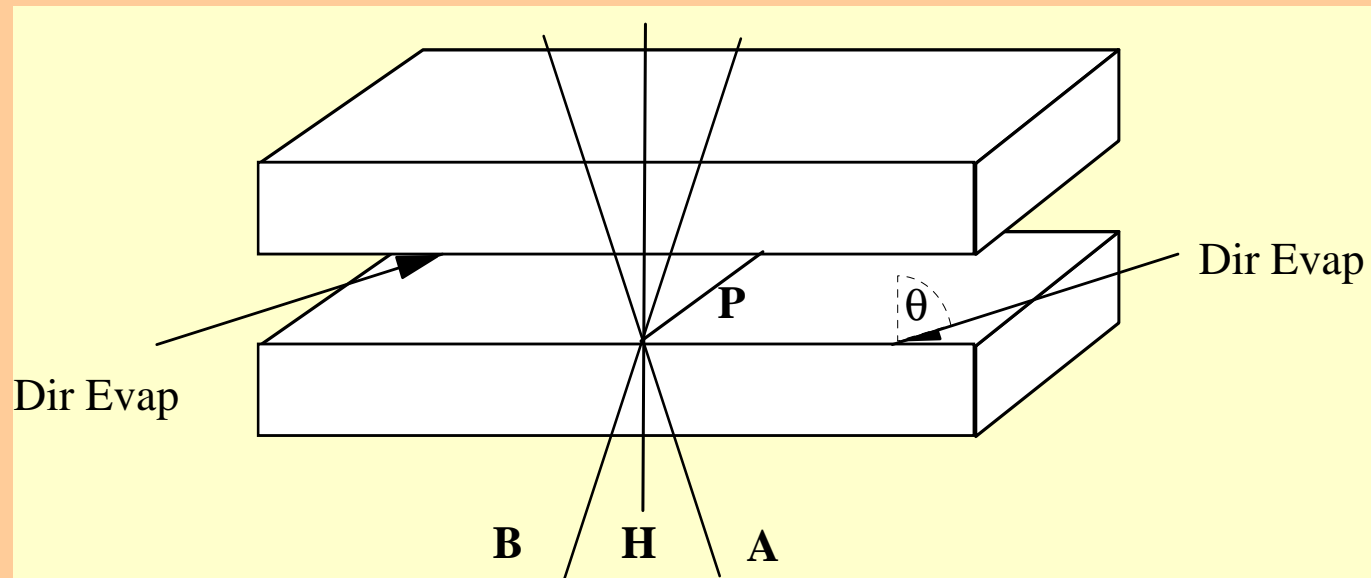
Microscopie optica

microscope in lumina polarizata

masuta incalzitoare

camera video

Experimental



Fascicul paralel

→ **Uniformitatea alinierii**

Fascicul convergent

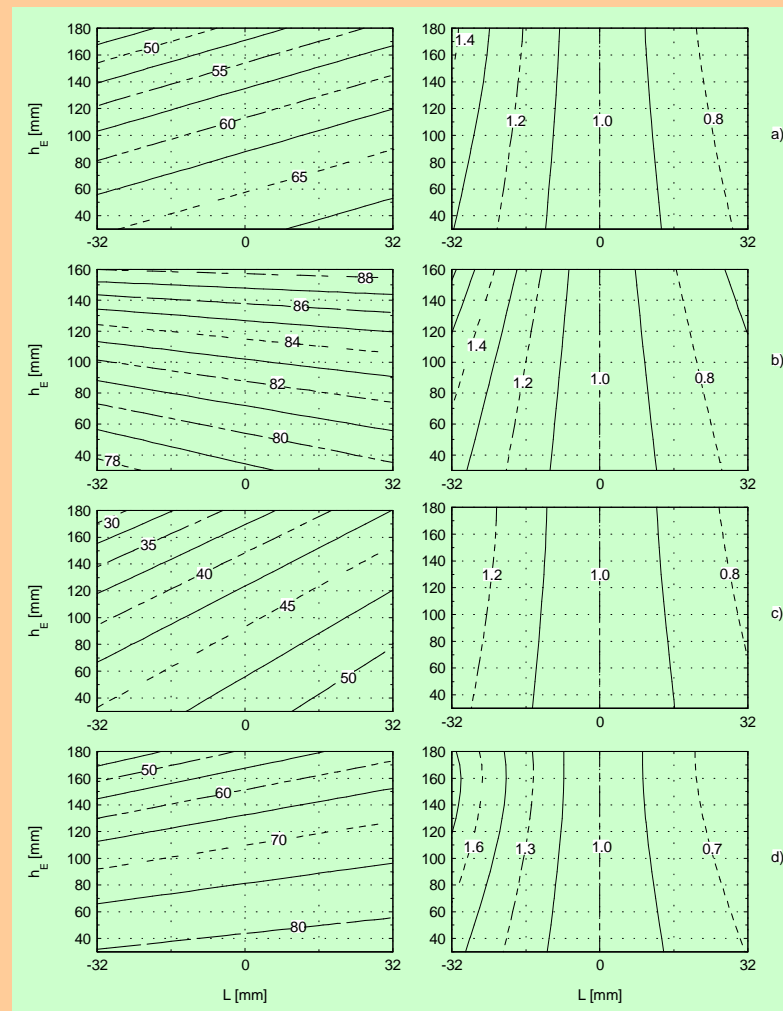
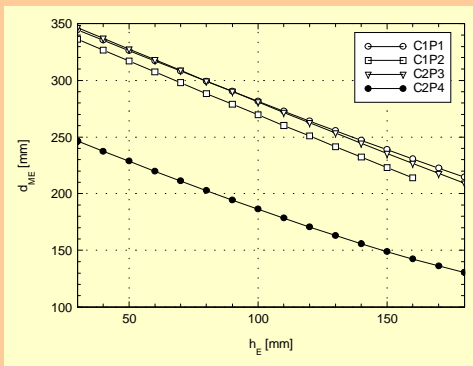
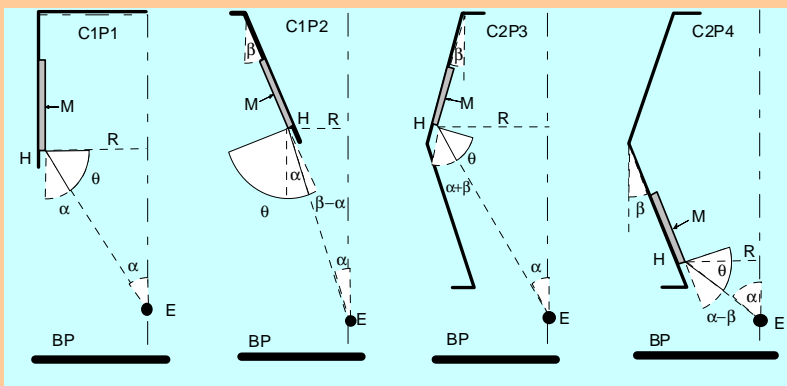
→ **Texturi inclinate A-H-B**

Aliniere tangentiala

→ **In planul evaporarii
Perpendicular pe plan**

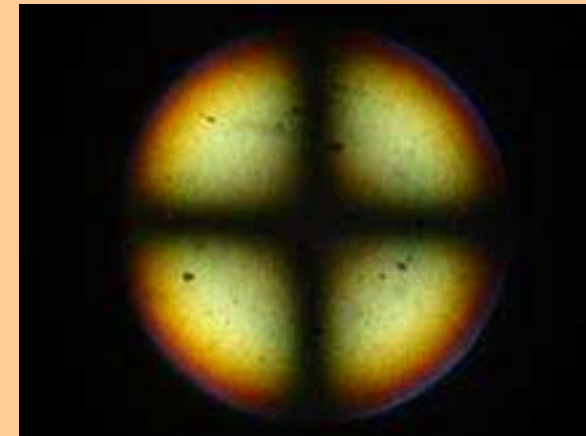
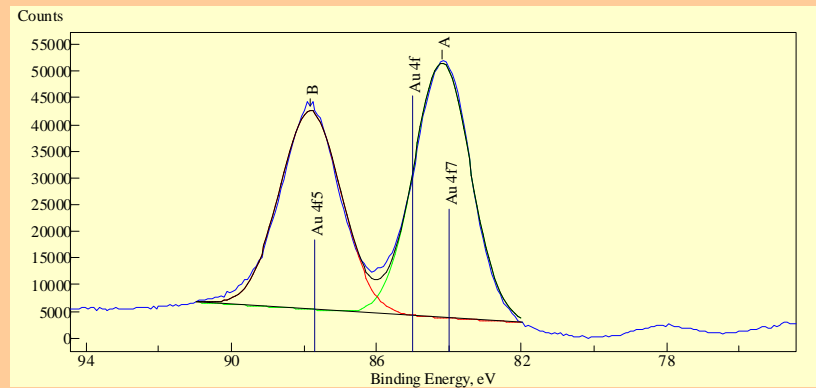
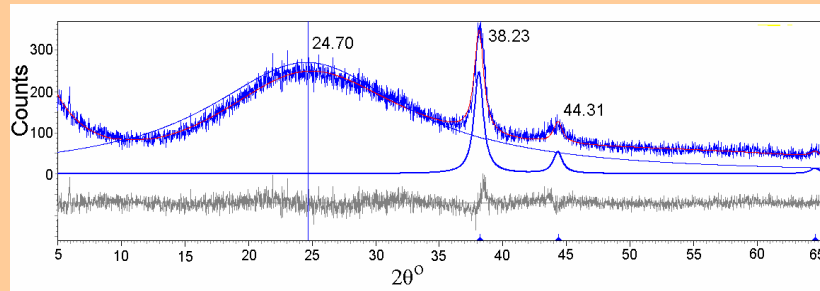
Aliniere homeotropa

REZULTATE A



T. Beica, S. Frunza, I. Zgura s.a., JOAM, 12, 347-353, 2010

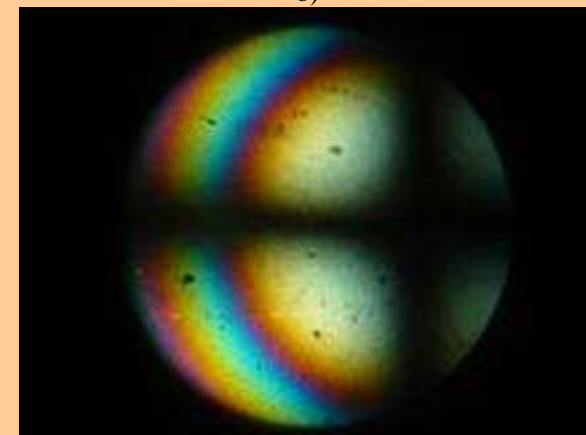
REZULTATE A



a)



b)

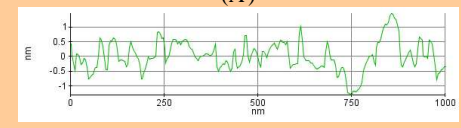
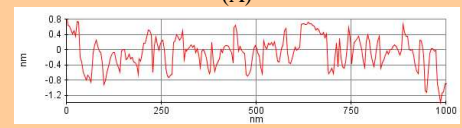
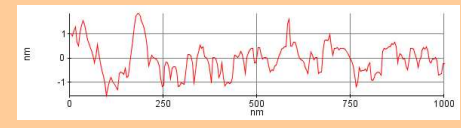
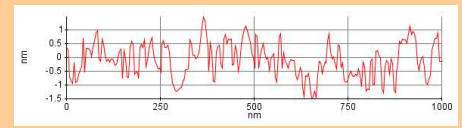
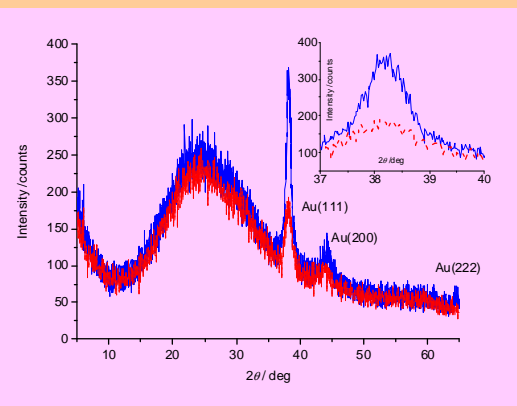
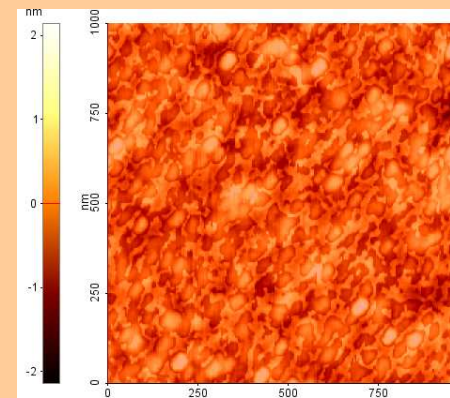
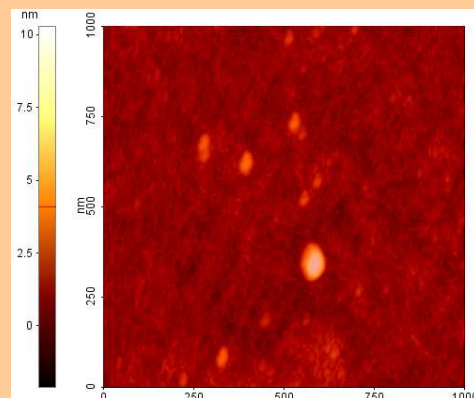
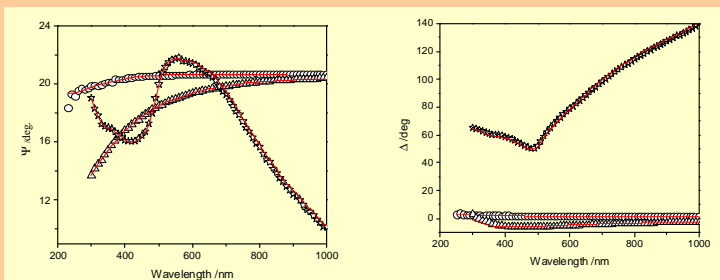


c)

T. Beica, S. Frunza, I. Zgura s.a., JOAM, 12, 347-353, 2010

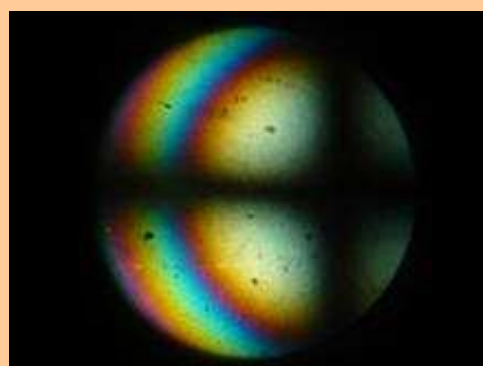
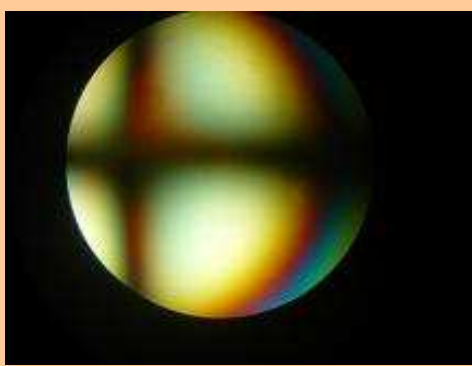
Seminarul National de Nanostiinta si Nanotehnologie, 16 martie 2010

REZULTATE B

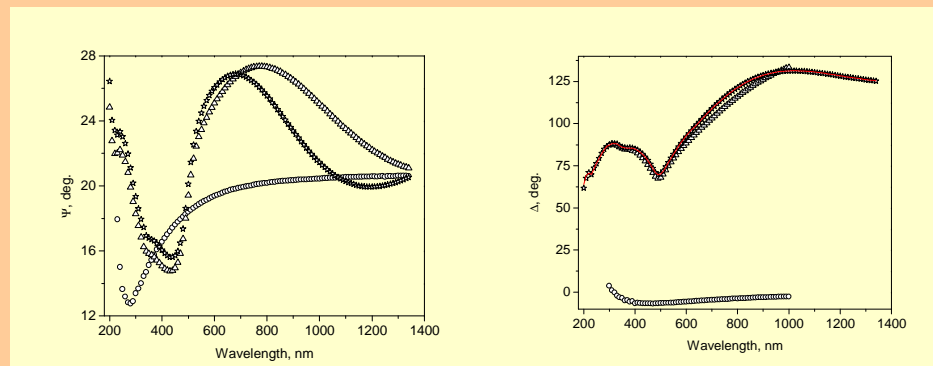
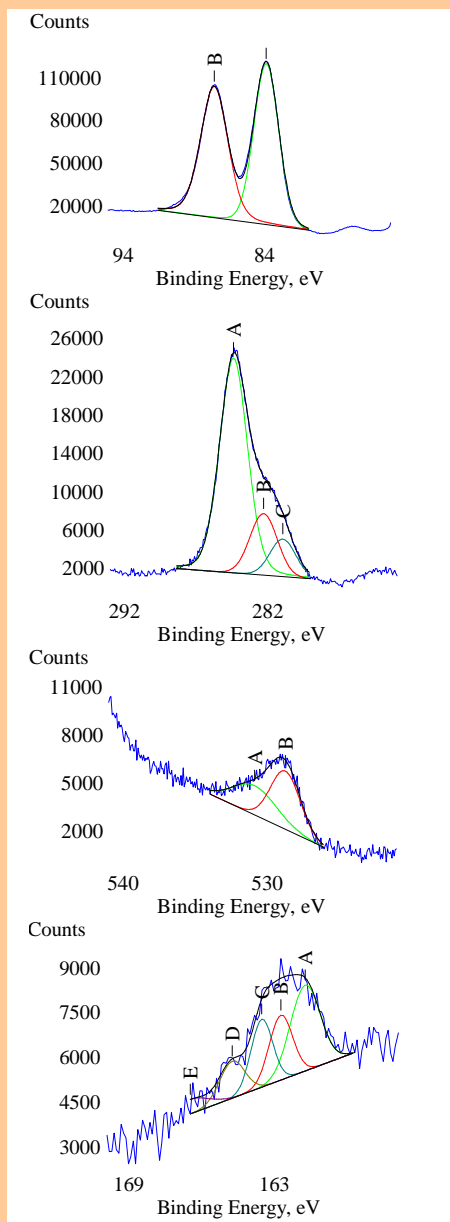


Rietveld analysis : Crystallites of 11.5 nm

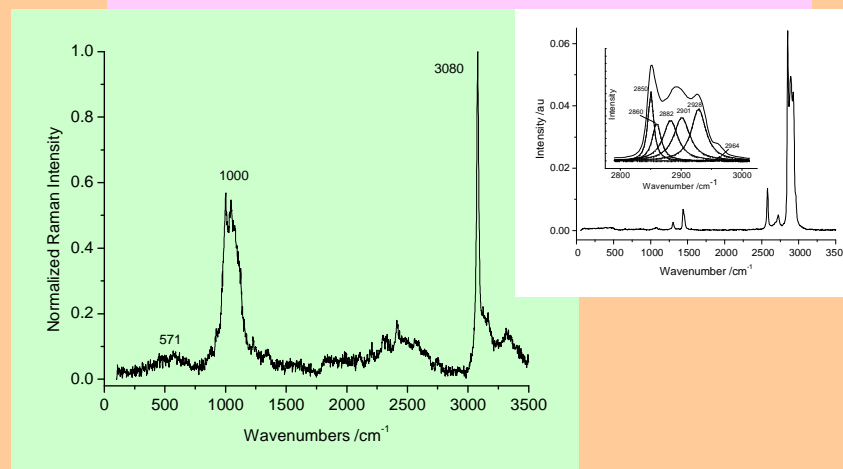
I. Zgura, T. Beica, S. Frunza s.a., JOAM, 12, 354-359, 2010



REZULTATE B



Layer\Sample	C16SH-P(3)	C16SH-P(4)
Polystyrene	51.3	51.0
Gold	7.3	9.1
SAM	0.8	1.2



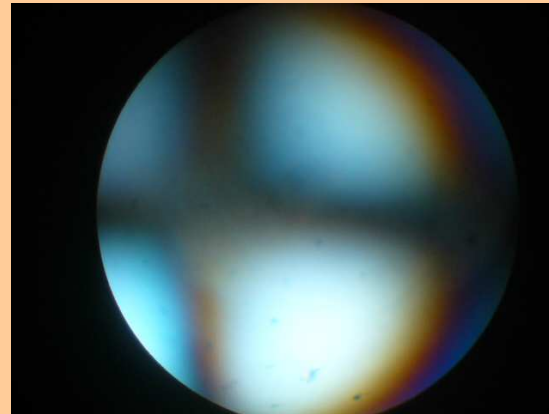
I Zgura, T. Beica, S. Frunza s.a., JOAM trimisa 2010

Seminarul National de Nanostiinta si Nanotehnologie, 16 martie 2010

REZULTATE B



(a)

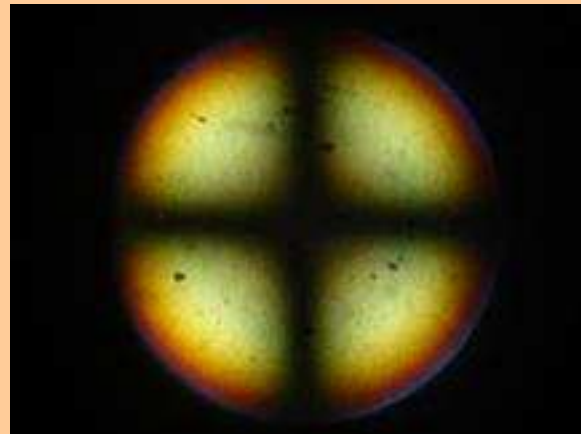


(b)

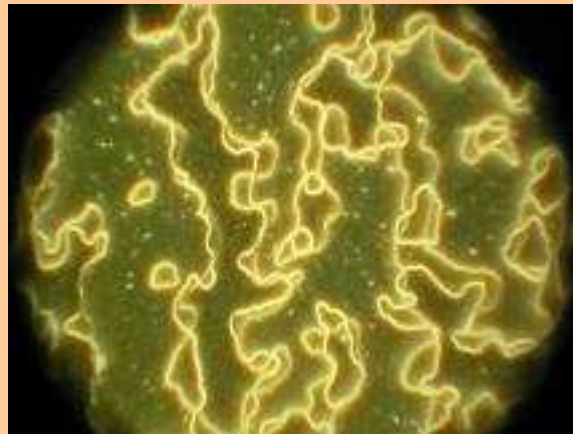
Substrat sticla

St: Au
($\theta=80^\circ, h_{Au}=120\text{\AA}$)

Dr: SAM/Au
($\theta=80^\circ, h_{Au}=120\text{\AA}$)



(a)



(b)

Substrat polistiren

St: Au
($\theta=60^\circ, h_{Au}=200\text{\AA}$)

Dr: SAM/ Au
($\theta=60^\circ, h_{Au}=200\text{\AA}$)

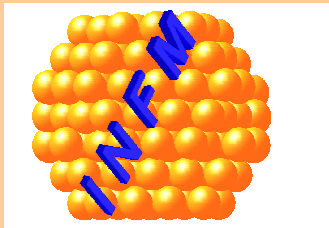
Concluzii

Straturi de aur nanostructurate pot fi obtinute si pe substrat de polistiren, cu aderenza buna.

Metoda observarii alinierii moleculelor de cristal lichid poate fi aplicata ca un element de control pe tot parcursul depunerii de straturi.

In cazurile fara SAM, orientarea este in planul de incidenta al vaporilor de aur. Unghiul de inclinare depinde de unghiul de incidenta si de grosimea stratului. Orientarea este fie perfect homeotropa, fie inclinata, slab sau puternic.

Functionalizarea cu tiol modifica orientarea moleculelor in functie de grosimea stratului si unghiul de depunere



Mulumiri

INCDFM

M. Baibarac *sp. Raman*
T. Velula

C. Cotarlan *XPS*
C. Negrila

A. M. Vlaicu *XRD*

O. Rasoga *Elipsometrie*
A. Galca

INFLPR

A. Moldovan *AFM*
M. Dinescu

Suport financiar

Ministerul Educatiei, Cercetarii si
(Proiectul VIRNANO/2007)

Va multumim pentru atentie